30V P-Channel PowerTrench[®] MOSFET

General Description

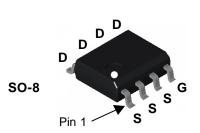
This PChannel MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gave drive voltage ratings (4.5V - 25V).

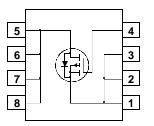
Applications

- Power management
- · Load switch
- Battery protection

Features

- -5.3 A, -30 V $R_{DS(ON)} = 50 \text{ m}\Omega @ V_{GS} = -10 \text{ V}$ $R_{DS(ON)} = 80 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- Low gate charge
- Fast switching speed
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





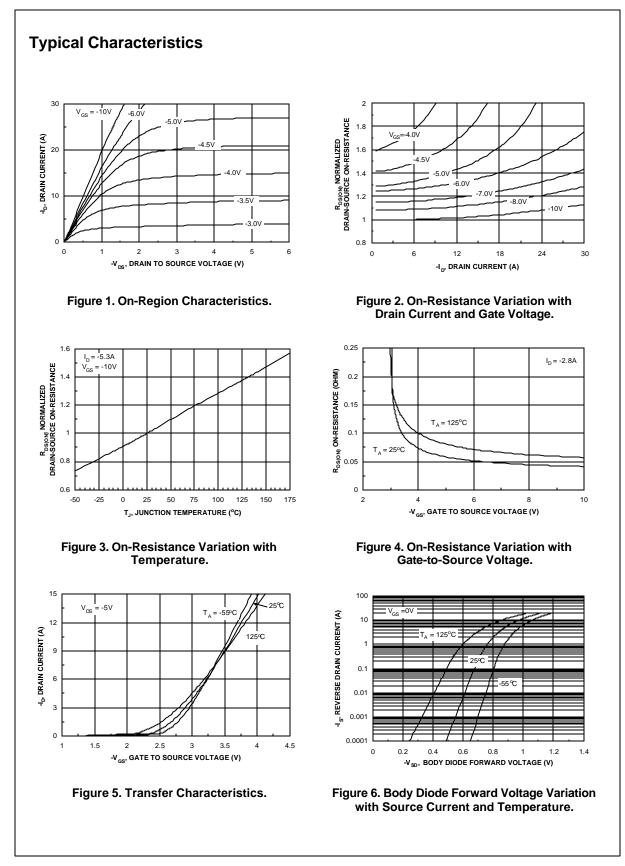
Absolute Maximum Ratings T_A=25°C unless otherwise noted

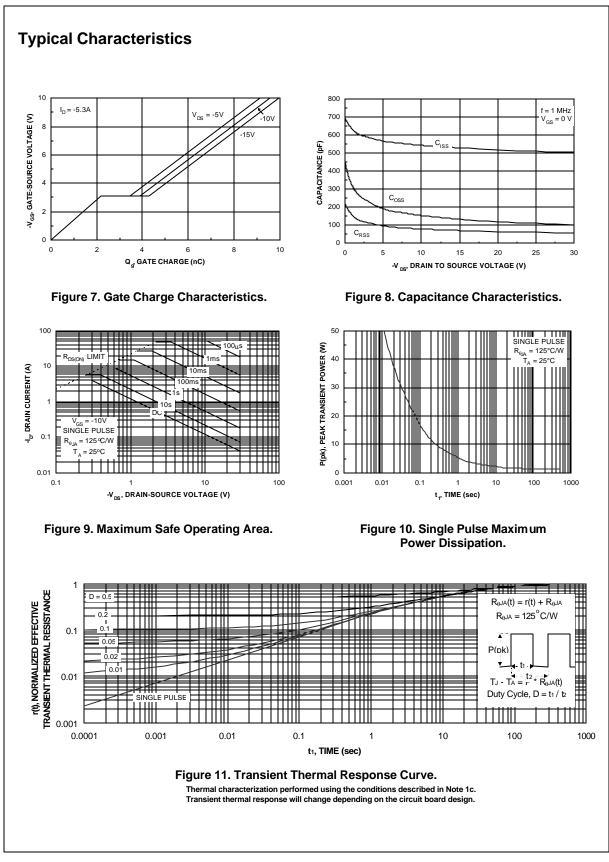
Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Sour	ce Voltage		-30	V
V _{GSS}	Gate-Source	ce Voltage		±25	V
D	Drain Current – Continuous		(Note 1a)	-5.3	A
	– Pulsed			-50	
PD	Power Dissipation for Single Operation		ation (Note 1a)	2.5	W
			(Note 1b)	1.2	
			(Note 1c)	1	
T _J , T _{STG}	Operating a	and Storage Junction Te	-55 to +175	°C	
Therma R _{0JA}	I Charac	teristics esistance, Junction-to-A	mbient (Note 1a)	50	°C/W
R _{0JA}	Thermal Resistance, Junction-to-Ambient		mbient (Note 1c)	125	°C/W
R _{0JC}	Thermal Re	esistance, Junction-to-C	Case (Note 1)	25	°C/W
Packag	e Markin	g and Ordering	Information		ŀ
i acray					
	Marking	Device	Reel Size	Tape width	Quantity

©2001 Fairchild Semiconductor Corporation

eristics ain–Source Breakdown Voltage eakdown Voltage Temperature pefficient	V _{GS} = 0 V, Ι _D = -250 μA				
ain–Source Breakdown Voltage eakdown Voltage Temperature	$V_{CS} = 0 V_{a} h_{B} = -250 \mu A$				1
e 1	100 0 1, D 200 pat	-30			V
	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		-23		mV/ºC
ero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA
ate–Body Leakage, Forward	$V_{GS} = 25 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
ate–Body Leakage, Reverse	$V_{GS} = -25 V$ $V_{DS} = 0 V$			-100	nA
eristics (Note 2)					
ate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-1.7	-3	V
ate Threshold Voltage	$I_D = -250 \ \mu$ A, Referenced to 25°C		4.5		mV/°C
atic Drain–Source	$V_{GS} = -10 \text{ V}, I_D = -5.3 \text{ A}$		42	50	mΩ
n-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -4 \text{ A}$		65	80	
	V_{GS} = -10 V, I_D = -5.3 A, T_J =125°C		57	77	
n–State Drain Current	$V_{GS} = -10 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-25			A
orward Transconductance	$V_{DS} = -5 V$, $I_{D} = -5.3 A$		10		S
haracteristics					
	$V_{DS} = -15 V$. $V_{CS} = 0 V$.		528		pF
utput Capacitance	f = 1.0 MHz		132		pF
			70		pF
Characteristics (use a)					
	$V_{pp} = -15 V$ $b = -1 A$		7	14	ns
,					ns
			-		ns
	-				ns
	$V_{pq} = -15 V_{pq} = -4 A_{pq}$		-		nC
	$V_{\rm DS} = -13$ V, $I_{\rm D} = -4$ A, $V_{\rm GS} = -10$ V		-	14	nC
					nC
3			Z		no
	-	-			
	Diode Forward Current			-2.1	A
	$V_{GS} = 0 V$, $I_{S} = -2.1 A$ (Note 2)		-0.8	-1.2	V
nage					
	eristics (Note 2) ate Threshold Voltage ate Threshold Voltage imperature Coefficient atic Drain–Source n–Resistance n–State Drain Current mward Transconductance naracteristics put Capacitance utput Capacitance everse Transfer Capacitance Characteristics (Note 2) Irn–On Delay Time Irn–Off Delay Time Irn–Off Fall Time tal Gate Charge ate–Drain Charge ce Diode Characteristics	ate-Body Leakage, Reverse $V_{GS} = -25 \vee V_{DS} = 0 \vee$ eristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \mu$ Aate Threshold Voltage $I_D = -250 \mu$ A, Referenced to 25° Cmperature Coefficient $I_D = -250 \mu$ A, Referenced to 25° Catic Drain-Source $V_{GS} = -10 \vee$, $I_D = -5.3 A$ $V_{CS} = -10 \vee$, $I_D = -5.3 A$, $V_{J} = 125^{\circ}$ C P -Resistance $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ P -Resistance $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ P -State Drain Current $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ P -State Drain Current $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ P -State Drain Current $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ P -Resistance $V_{DS} = -5 \vee$, $I_D = -5.3 \wedge$ P -Resistance $V_{DS} = -15 \vee$, $V_{DS} = 0 \vee$, P -Resistance $V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$, P -Resistance $V_{DD} = -15 \vee$, $V_{GS} = 0 \vee$, P -Resistance $V_{DD} = -15 \vee$, $I_D = -1 \wedge$, P -Resistance $V_{DD} = -15 \vee$, $I_D = -1 \wedge$, P -Resistance $V_{DS} = -10 \vee$, $R_{GEN} = 6 \Omega$ P -Resistance $V_{DS} = -10 \vee$, $I_D = -4 \wedge$, $V_{CS} = -10 \vee$ $V_{CS} = -10 \vee$ P -Resistance $V_{DS} = -15 \vee$, $I_D = -4 \wedge$, $V_{CS} = -10 \vee$ $V_{CS} = -10 \vee$ P -Resistance $V_{CS} = -0 \vee$ </td <td>ate-Body Leakage, Reverse$V_{GS} = -25 \vee V_{DS} = 0 \vee$eristics(Note 2)ate Threshold Voltage$V_{DS} = V_{GS}$, $b = -250 \mu$A-1ate Threshold Voltage$b = -250 \mu$A, Referenced to 25°Cmperature Coefficient$b = -250 \mu$A, Referenced to 25°Catic Drain-Source$V_{GS} = -10 \vee$, $b = -5.3 A$$-Resistance$$V_{GS} = -10 \vee$, $b = -5.3 A$, $T_J = 125^{\circ}$C$-Resistance$$V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$$-25$ mward Transconductance$V_{DS} = -5 \vee$, $b = -5.3 A$hracteristics$V_{DS} = -5 \vee$, $b = -5.3 A$but Capacitance$V_{DS} = -5 \vee$, $b = -5.3 A$hracteristics$V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$,f = 1.0 MHz$V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$,true-On Delay Time$V_{DD} = -15 \vee$, $b = -1 A$,Im-On Delay Time$V_{DS} = -10 \vee$, $R_{GEN} = 6 \Omega$Im-Off Delay Time$V_{DS} = -15 \vee$, $b = -4 A$,$V_{GS} = -10 \vee$, $R_{GEN} = 6 \Omega$Im-Off Fall Time$V_{DS} = -10 \vee$tal Gate Charge$V_{DS} = -15 \vee$, $b = -4 A$,$V_{GS} = -10 \vee$$V_{CS} = -10 \vee$ate-Drain Charge$V_{DS} = -15 \vee$, $b = -4 A$,$V_{GS} = -10 \vee$$R_{GEN} = 6 \Omega$tal Gate Charge$V_{CS} = -10 \vee$tal Gate Charge$V_{CS} = 0 \vee$tal Gate Charge$V_{CS} = 0$</td> <td>ate-Body Leakage, Reverse$V_{GS} = -25 \vee V_{DS} = 0 \vee$eristics(Note 2)ate Threshold Voltage$V_{DS} = V_{GS}$, $b = -250 \mu$A-1ate Threshold Voltage$b = -250 \mu$A, Referenced to 25°C4.5ate Threshold Voltage$b = -250 \mu$A, Referenced to 25°C4.5ate Threshold Voltage$V_{GS} = -10 \vee$, $b = -5.3 A$$42$mperature Coefficient$V_{GS} = -10 \vee$, $b = -5.3 A$$42$ate Transconce$V_{GS} = -10 \vee$, $b = -5.3 A$, $T_J=125^{\circ}$C57m-State Drain Current$V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$$-25$orward Transconductance$V_{DS} = -5 \vee$, $b = -5.3 A$10maracteristics$V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$,528out Capacitance$f = 1.0 \text{ MHz}$$132$werse Transfer Capacitance$V_{DS} = -15 \vee$, $b = -1 A$,7rm-On Delay Time$V_{DS} = -10 \vee$, $R_{GEN} = 6 \Omega$$13$rm-Off Fall Time$V_{GS} = -10 \vee$$2.2$ate-Source Charge$V_{CS} = -10 \vee$$2.2$ate-Drain Charge$2$$2$ce Diode Characteristics and Maximum Ratings2aximum Continuous Drain-Source Diode Forward Current-0.8</td> <td>tate-Body Leakage, Reverse$V_{GS} = -25 \vee V_{DS} = 0 \vee$-100eristics(Note 2)ate Threshold Voltage$V_{DS} = V_{GS}$, $b = -250 \ \mu$A, Referenced to 25°C4.5mperature Coefficient$b = -250 \ \mu$A, Referenced to 25°C4.5atic Drain-Source$V_{GS} = -10 \ V$, $b = -5.3 \ A$42Resistance$V_{GS} = -10 \ V$, $b = -5.3 \ A$, $T_J = 125^{\circ}$C57State Drain Current$V_{GS} = -10 \ V$, $v_{DS} = -5 \ V$-25Nexarcteristics$V_{DS} = -10 \ V$, $V_{DS} = -5 \ V$-25Nexarcteristics$V_{DS} = -15 \ V$, $b = -5.3 \ A$10Naracteristics$V_{DS} = -15 \ V$, $V_{GS} = 0 \ V$,528</td>	ate-Body Leakage, Reverse $V_{GS} = -25 \vee V_{DS} = 0 \vee$ eristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}$, $b = -250 \mu$ A-1ate Threshold Voltage $b = -250 \mu$ A, Referenced to 25° Cmperature Coefficient $b = -250 \mu$ A, Referenced to 25° Catic Drain-Source $V_{GS} = -10 \vee$, $b = -5.3 A$ $-Resistance$ $V_{GS} = -10 \vee$, $b = -5.3 A$, $T_J = 125^{\circ}$ C $-Resistance$ $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ -25 mward Transconductance $V_{DS} = -5 \vee$, $b = -5.3 A$ hracteristics $V_{DS} = -5 \vee$, $b = -5.3 A$ but Capacitance $V_{DS} = -5 \vee$, $b = -5.3 A$ hracteristics $V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$,f = 1.0 MHz $V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$,true-On Delay Time $V_{DD} = -15 \vee$, $b = -1 A$,Im-On Delay Time $V_{DS} = -10 \vee$, $R_{GEN} = 6 \Omega$ Im-Off Delay Time $V_{DS} = -15 \vee$, $b = -4 A$, $V_{GS} = -10 \vee$, $R_{GEN} = 6 \Omega$ Im-Off Fall Time $V_{DS} = -10 \vee$ tal Gate Charge $V_{DS} = -15 \vee$, $b = -4 A$, $V_{GS} = -10 \vee$ $V_{CS} = -10 \vee$ ate-Drain Charge $V_{DS} = -15 \vee$, $b = -4 A$, $V_{GS} = -10 \vee$ $R_{GEN} = 6 \Omega$ tal Gate Charge $V_{CS} = -10 \vee$ tal Gate Charge $V_{CS} = 0 \vee$ tal Gate Charge $V_{CS} = 0 $	ate-Body Leakage, Reverse $V_{GS} = -25 \vee V_{DS} = 0 \vee$ eristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}$, $b = -250 \mu$ A -1 ate Threshold Voltage $b = -250 \mu$ A, Referenced to 25° C 4.5 ate Threshold Voltage $b = -250 \mu$ A, Referenced to 25° C 4.5 ate Threshold Voltage $V_{GS} = -10 \vee$, $b = -5.3 A$ 42 mperature Coefficient $V_{GS} = -10 \vee$, $b = -5.3 A$ 42 ate Transconce $V_{GS} = -10 \vee$, $b = -5.3 A$, $T_J=125^{\circ}$ C 57 m-State Drain Current $V_{GS} = -10 \vee$, $V_{DS} = -5 \vee$ -25 orward Transconductance $V_{DS} = -5 \vee$, $b = -5.3 A$ 10maracteristics $V_{DS} = -15 \vee$, $V_{GS} = 0 \vee$, 528 out Capacitance $f = 1.0 \text{ MHz}$ 132 werse Transfer Capacitance $V_{DS} = -15 \vee$, $b = -1 A$, 7 rm-On Delay Time $V_{DS} = -10 \vee$, $R_{GEN} = 6 \Omega$ 13 rm-Off Fall Time $V_{GS} = -10 \vee$ 2.2 ate-Source Charge $V_{CS} = -10 \vee$ 2.2 ate-Drain Charge 2 2 ce Diode Characteristics and Maximum Ratings 2 aximum Continuous Drain-Source Diode Forward Current -0.8	tate-Body Leakage, Reverse $V_{GS} = -25 \vee V_{DS} = 0 \vee$ -100eristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}$, $b = -250 \ \mu$ A, Referenced to 25° C4.5mperature Coefficient $b = -250 \ \mu$ A, Referenced to 25° C4.5atic Drain-Source $V_{GS} = -10 \ V$, $b = -5.3 \ A$ 42Resistance $V_{GS} = -10 \ V$, $b = -5.3 \ A$, $T_J = 125^{\circ}$ C57State Drain Current $V_{GS} = -10 \ V$, $v_{DS} = -5 \ V$ -25Nexarcteristics $V_{DS} = -10 \ V$, $V_{DS} = -5 \ V$ -25Nexarcteristics $V_{DS} = -15 \ V$, $b = -5.3 \ A$ 10Naracteristics $V_{DS} = -15 \ V$, $V_{GS} = 0 \ V$,528

FDS9435A Rev D1(W)





FDS9435A Rev D1(W)

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™ Bottomless™ CoolFET™ CROSSVOLT™ DenseTrench™ DOME™ **EcoSPARK™** E²CMOS[™] EnSigna™ FACT™ FACT Quiet Series™ FAST ® FASTr™ FRFET™ GlobalOptoisolator[™] POP[™] GTO™ HiSeC™ ISOPLANAR™ LittleFET™ MicroFET™ MicroPak™ MICROWIRE™

OPTOLOGIC™ OPTOPLANAR™ PACMAN™ Power247™ PowerTrench[®] QFET™ QS™ QT Optoelectronics[™] Quiet Series[™] SILENT SWITCHER®

SMART START™ VCX™ STAR*POWER™ Stealth™ SuperSOT[™]-3 SuperSOT[™]-6 SuperSOT[™]-8 SyncFET™ TinyLogic™ TruTranslation[™] UHC™ UltraFET[®]

STAR*POWER is used under license

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY. FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.			
	In Design First Production Full Production			

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: <u>FDS9435A</u>